Inventor:

F rnando Gonzalez

Title:

Methods of F rming Semiconductor Constructions

Assignee:

Micron Techn logy, Inc.

PRIORITY Serial No.:

09/592,604

PRIORITY Filing Date:

June 12, 2000

INFORMATION DISCLOSURE STATEMENT

PURSUANT TO 37 C.F.R. §§1.56, 1.97 AND 1.98

In compliance with 37 C.F.R. §§1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449.

The listed references were cited by, or submitted to, the Office in the parent, co-pending application of the above-identified application. The above-identified application is a continuation of co-pending application Serial No. 09/592,604 filed June 12, 2000. Such prior disclosure is sufficient for the above-identified application as far as copies of the references are concerned. 37 C.F.R. §1.98(d) and MPEP §609(2). No admission is made regarding whether all the submitted references are prior art.

Citation of these references is respectfully requested.

Respectfully submitted,

Data

September 9, 2003 Attorney:

David G. Latwesen, Ph.D.

Reg. No. 38,533

Wells, St. John P.S.

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. MI22-2393			PRIORITY SERIAL NO. 09/592,604		
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	AR		Gösele, U. et al.,	"Semiconductor	Wafer Bonding: Science, Techn	nology, and Applicatio	ns", Electroc	hemica	al Socie	ty Proceeding	;s
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